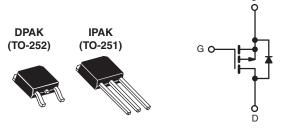


**Vishay Siliconix** 

#### **Power MOSFET**

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	- 50				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = - 10 V 0.28				
Q <sub>g</sub> (Max.) (nC)	14				
Q <sub>gs</sub> (nC)	6.5				
Q <sub>gd</sub> (nC)	6.5				
Configuration	Single				



P-Channel MOSFET

#### FEATURES

- Surface Mountable (Order As IRFR9020/SiHFR9020)
- Straight Lead Option (Order As IRFU9020/SiHFU9020)
- Repetitive Avalanche Ratings
- Dynamic dV/dt Rating
- Simple Drive Requirements
- Ease of Paralleling
- · Lead (Pb)-free Available

#### DESCRIPTION

The Power MOSFET technology is the key to Vishay's advanced line of Power MOSFET transistors. The efficient geometry and unique processing of this latest "State of the Art" design achieves: very low on-state resistance combined with high transconductance; superior reverse energy and diode recovery dV/dt.

The Power MOSFET transistors also feature all of the well established advantages of MOSFET'S such as voltage control, very fast switching, ease of paralleling and temperature stability of the electrical parameters.

Surface mount packages enhance circuit performance by reducing stray inductances and capacitance. The TO-252 surface mount package brings the advantages of Power MOSFET's to high volume applications where PC Board surface mounting is desirable. The surface mount option IRFR9020/SiHFR9020 is provided on 16mm tape. The straight lead option IRFR9020/SiHFR9020 of the device is called the IPAK (TO-251).

They are well suited for applications where limited heat dissipation is required such as, computers and peripherals, telecommunication equipment, DC/DC converters, and a wide range of consumer products.

ORDERING INFORMATION						
Package	DPAK (TO-252)	DPAK (TO-252)	DPAK (TO-252)	IPAK (TO-251)		
Lead (Pb)-free	IRFR9020PbF	IRFR9020TRPbF <sup>a</sup>	IRFR9020TRLPbF <sup>a</sup>	IRFU9020PbF		
	SiHFR9020-E3	SiHFR9020T-E3 <sup>a</sup>	SiHFR9020TL-E3 <sup>a</sup>	SiHFU9020-E3		
SnPb	IRFR9020	IRFR9020TR <sup>a</sup>	IRFR9020TRL <sup>a</sup>	IRFU9020		
511PD	SiHFR9020	SiHFR9020T <sup>a</sup>	SiHFR9020TL <sup>a</sup>	SiHFU9020		

Note

a. See device orientation.

<b>ABSOLUTE MAXIMUM RATINGS</b> $T_C = 25 \text{ °C}$ , unless otherwise noted							
PARAMETER	SYMBOL	LIMIT	UNIT				
Drain-Source Voltage	V <sub>DS</sub>	- 50	V				
Gate-Source Voltage	V <sub>GS</sub>	± 20	v				
Continuous Drain Current	$V_{GS}$ at - 10 V $T_C = 25 \degree C$ $T_C = 100 \degree C$	1	- 9.9				
	$V_{GS}$ at - 10 V $T_C = 100 ^{\circ}C$	ID	- 6.3	А			
Pulsed Drain Current <sup>a</sup>	I <sub>DM</sub>	- 40					
Linear Derating Factor		0.33	W/°C				
Single Pulse Avalanche Energy <sup>b</sup>	E <sub>AS</sub>	440	mJ				
Repetitive Avalanche Current <sup>a</sup>	I <sub>AR</sub>	- 9.9	A				
Repetitive Avalanche Energy <sup>a</sup>	E <sub>AR</sub>	4.2	mJ				

\* Pb containing terminations are not RoHS compliant, exemptions may apply



RoHS

COMPLIANT

# Vishay Siliconix



<b>ABSOLUTE MAXIMUM RATINGS</b> $T_C = 25 \degree C$ , unless otherwise noted							
PARAMETER	SYMBOL	LIMIT	UNIT				
Maximum Power Dissipation	PD	42	W				
Peak Diode Recovery dV/dt <sup>c</sup>	dV/dt	5.8	V/ns				
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C				
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>	C			

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 14). b.  $V_{DD} = -25$  V, Starting  $T_J = 25$  °C, L = 5.1 mH,  $R_G = 25 \Omega$ , Peak  $I_L = -9.9$  A c.  $I_{SD} \le -9.9$  A, dl/dt  $\le -120$  A/µs,  $V_{DD} \le 40$  V,  $T_J \le 150$  °C. d. 0.063" (1.6 mm) from case. e. When mounted on 1" square PCB (FR-4 or G-10 material).

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	-	110		
Case-to-Sink	R <sub>thCS</sub>	-	1.7	-	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	-	3.0		

<b>SPECIFICATIONS</b> $T_J = 25 \text{ °C}$ , unless otherwise noted								
PARAMETER	SYMBOL	Т	MIN.	TYP.	MAX.	UNIT		
Static	•				•			
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>G</sub>	<sub>S</sub> = 0 V, I <sub>D</sub> = - 250 μA	- 50	-	-	V	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub>	<sub>S</sub> = V <sub>GS</sub> , I <sub>D</sub> = - 250 μA	- 2.0	-	- 4.0	V	
Gate-Source Leakage	I <sub>GSS</sub>		$V_{GS} = \pm 20 \text{ V}$	-	-	± 500	nA	
Zaro Cata Valtaga Drain Current		V <sub>DS</sub> =	max. rating, V <sub>GS</sub> = 0 V	-	-	250		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 0.8 x m	ax. rating, $V_{GS} = 0 \text{ V}$ , $T_{J} = 125 \text{ °C}$	-	-	1000	μA	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = -10 V$ $I_D = 5.7 A^b$		-	0.20	0.28	Ω	
Forward Transconductance	9 <sub>fs</sub>	$V_{DS} \le$ - 50 V, $I_{DS}$ = - 5.7 A		2.3	3.5	-	S	
Dynamic	·							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = - 25 V, f = 1.0 MHz, see fig. 9		-	490	-	pF	
Output Capacitance	C <sub>oss</sub>			-	320	-		
Reverse Transfer Capacitance	C <sub>rss</sub>			-	70	-		
Total Gate Charge	Qg		$V_{GS} = -10 V$ $I_D = -9.7 A, V_{DS} = 0.8 x max.$ rating, see fig. 16 (Independent operating		9.4	14		
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = -10 V$			4.3	6.5	nC	
Gate-Drain Charge	Q <sub>gd</sub>		temperature)	-	4.3	6.5		
Turn-On Delay Time	t <sub>d(on)</sub>			-	8.2	12		
Rise Time	t <sub>r</sub>		$V_{DD} = -25 V, I_D = -9.7 A,$		57	66		
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_G = 18 \Omega$ , $R_D = 2.4 \Omega$ , see fig. 15 (Independent operating temperature)		-	12	18	ns	
Fall Time	t <sub>f</sub>		( ,			38		
Internal Drain Inductance	L <sub>D</sub>	6 mm (0.25	Between lead, 6 mm (0.25") from		4.5	-	~LJ	
Internal Source Inductance	L <sub>S</sub>	package an die contact.		-	7.5	-	nH	



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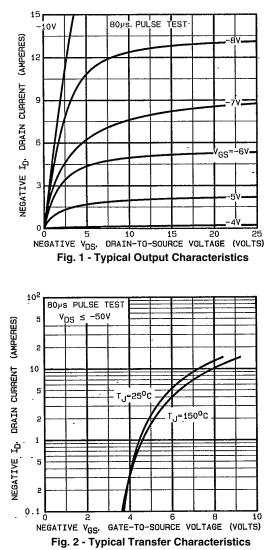
<b>SPECIFICATIONS</b> $T_J = 25 \text{ °C}$ , unless otherwise noted								
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT		
Drain-Source Body Diode Characteristics								
Continuous Source-Drain Diode Current	١ <sub>S</sub>	MOSFET symbol showing the	-	-	- 9.9	A		
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	p - n junction diode	-	-	- 40	A		
Body Diode Voltage	V <sub>SD</sub>	$T_J$ = 25 °C, $I_S$ = - 9.9 A, $V_{GS}$ = 0 V <sup>b</sup>	-	-	- 6.3	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = - 9,7 A, dl/dt = 100 A/μs <sup>b</sup>	56	110	280	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$T_{\rm J} = 25$ °C, $T_{\rm F} = -9,7$ Å, di/dl = 100 Å/µs <sup>3</sup>	0.17	0.34	0.85	nC		
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by $L_{\text{S}}$ and $L_{\text{D}})$						

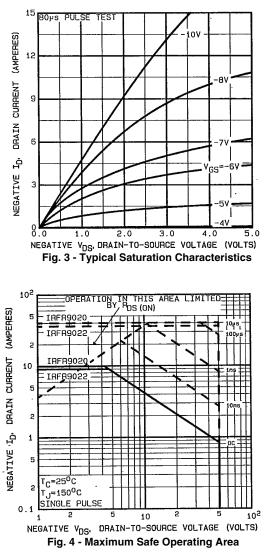
#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 14).

b. Pulse width  $\leq$  300  $\mu s;$  duty cycle  $\leq$  2 %.

#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted







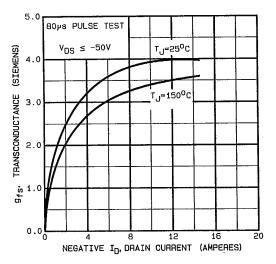


Fig. 5 - Typical Transconductance vs. Drain Current

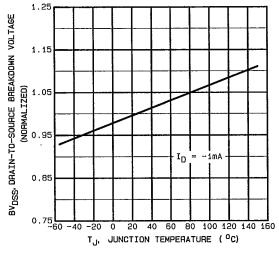


Fig. 7 - Breakdown Voltage vs. Temperature

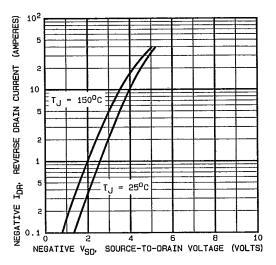


Fig. 6 - Typical Source-Drain Diode Forward Voltage

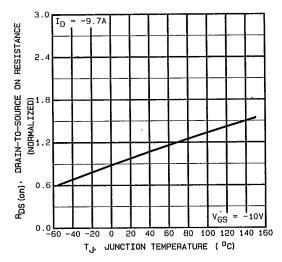


Fig. 8 - Normalized On-Resistance vs. Temperature



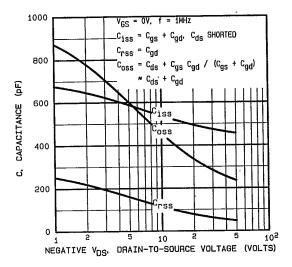


Fig. 9 - Typical Capacitance vs. Drain-to-Source Voltage

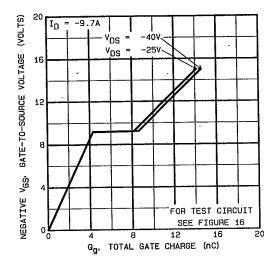


Fig. 10 - Typical Gate Charge vs. Gate-to-Source Voltage

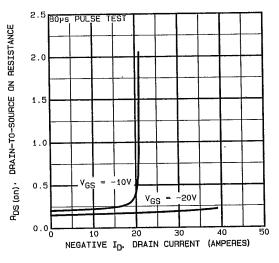


Fig. 11 - Typical On-Resistance vs. Drain Current

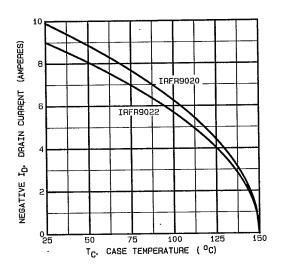


Fig. 12 - Maximum Drain Current vs. Case Temperature



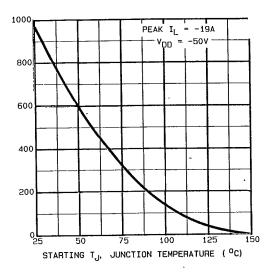


Fig. 13a - Maximum Avalanche vs. Starting Junction Temperature

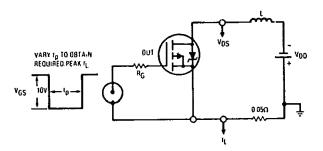


Fig. 13b - Unclamped Inductive Test Circuit

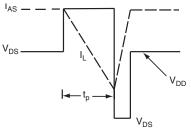


Fig. 13c - Unclamped Inductive Waveforms

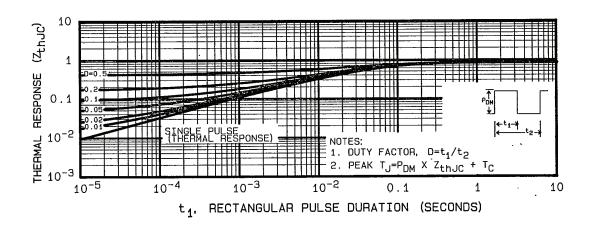


Fig. 14 - Maximum Effective Transient Thermal Impedance, Junction-to-Case vs. Pulse Duration



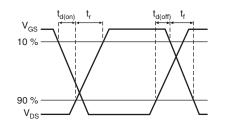


Fig. 15a - Switching Time Waveforms

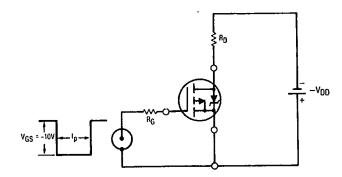


Fig. 15b - Switching Time Test Circuit

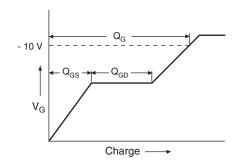
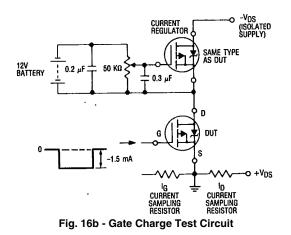
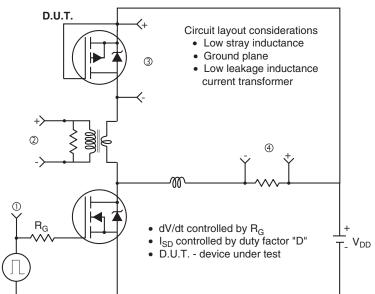


Fig. 16a - Basic Gate Charge Waveform



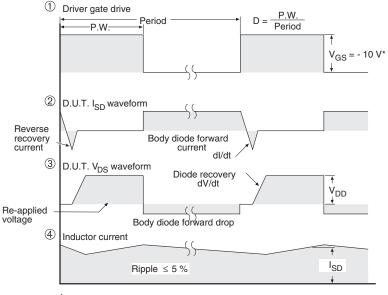
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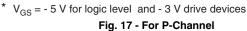




#### Peak Diode Recovery dV/dt Test Circuit

• Compliment N-Channel of D.U.T. for driver





Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?90350.



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